

Effective Bits
A Not-so-New Way
to Characterize
Data Acquisition System
Accuracy

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Accuracy

Is the *First Question* Your
Customer Will Ask You

and

Is the *Hardest Parameter* to
Characterize and Describe.

Accuracy... What Does It Mean?

A Description of the *Fidelity* With Which a System Can Measure and Reproduce a Real-World Phenomenon.

The Question is: In What Sense?

Instantaneous Time History ... What is the Accuracy of Each Point?

Worst Case of a Group (Peak-Peak)
RMS Error of a Group

Averaged Time History ... What is the Accuracy if We Average Several Points?

Single Block Spectrum ... If We Calculate the Spectrum, How Accurate Is It?

Ensemble-Averaged Spectrum ... What is the Spectral Accuracy if Averaging is Included?

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- Different *Laboratories* and Different *Vendors* Use Different Definitions.
 - Often, the Proper Definition Depends on the Test to be Performed.
 - Often, the Definition is *Not* Described in the Hardware Specification.

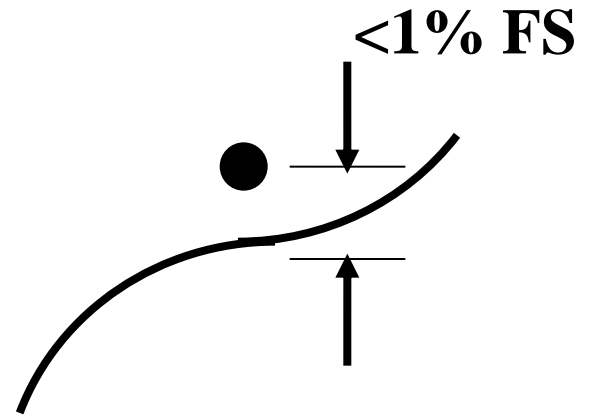
Accuracy .. What Do I Mean?

What Makes Sense is

Individual

Point

Definition



What Do We Want To Do

Characterize the System Under a Simulation of

“Real” Conditions.

- Varying Signal
- “Exercise” Full Range of System
- Look at Every Point

Approach:

Use a Sine Wave to Drive the System

The Concept is Called

Effective Bits

although this is a Misnomer

...Dynamic Range and

Non-Linearity

are what Counts

Effective Bits.. Test Setup/Process

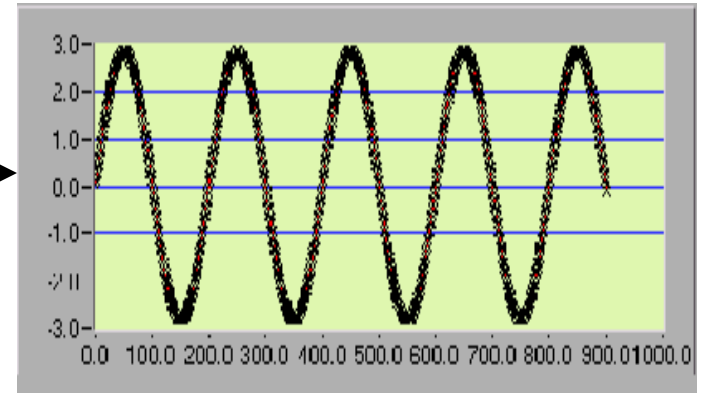
**Ultra-Low
Distortion
Sine
Oscillator**

$F \sim \text{Sample Rate}/100$
 $\text{Amplitude} = .95 * \text{FSR}$

**Data
Acquisition
System**

**Variables:
Sample Rate
Gain**

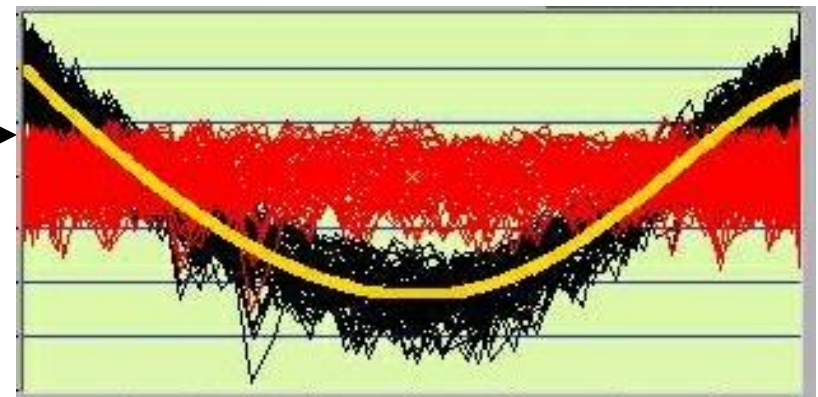
10-100 Cycles



“Error”

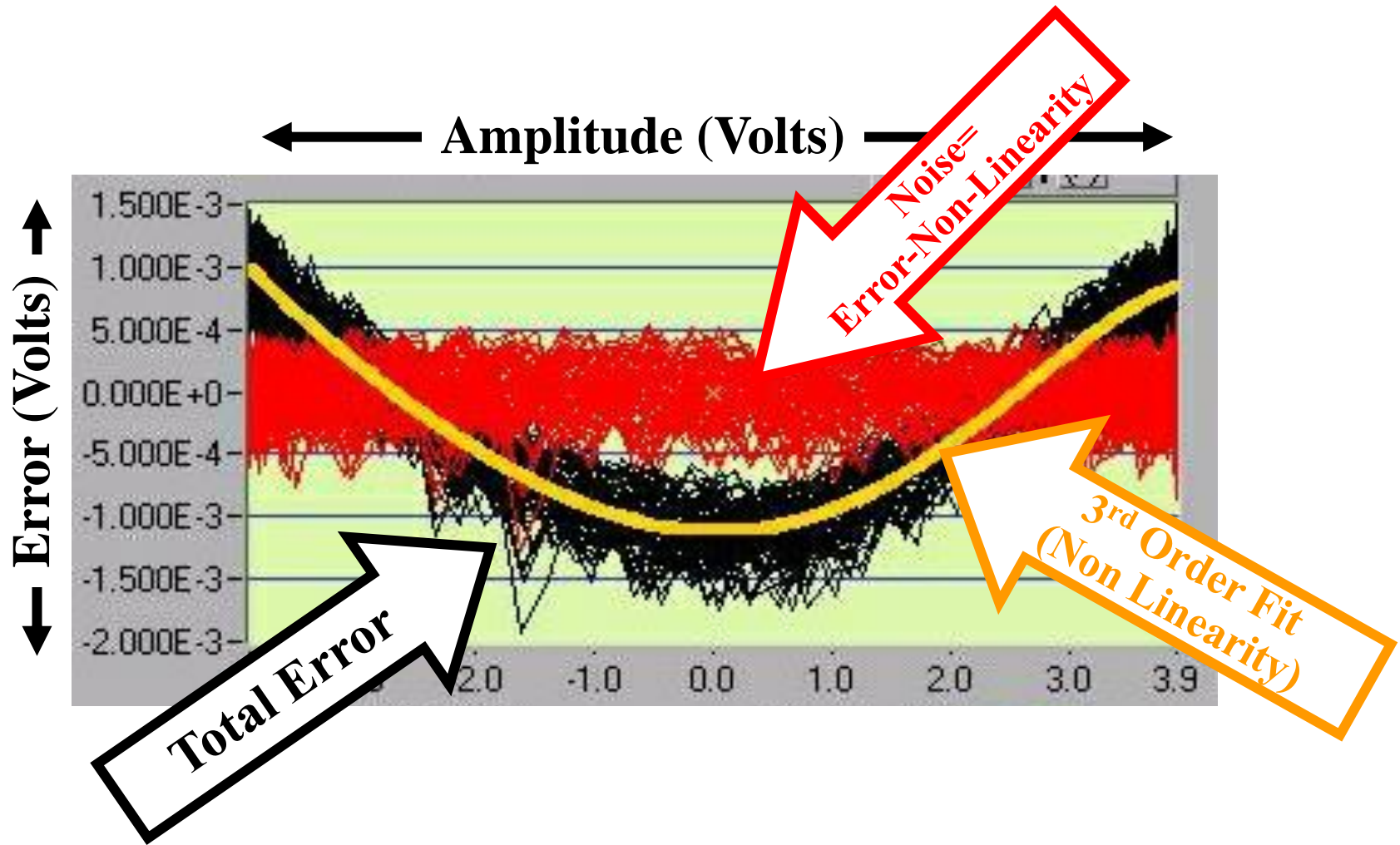
**Least-Square
Curve Fit**
 $y = a + b * \sin(cx + d)$

Gain Error (Normalized)
 $= (\text{True Amp} - b) / \text{True Amp}$



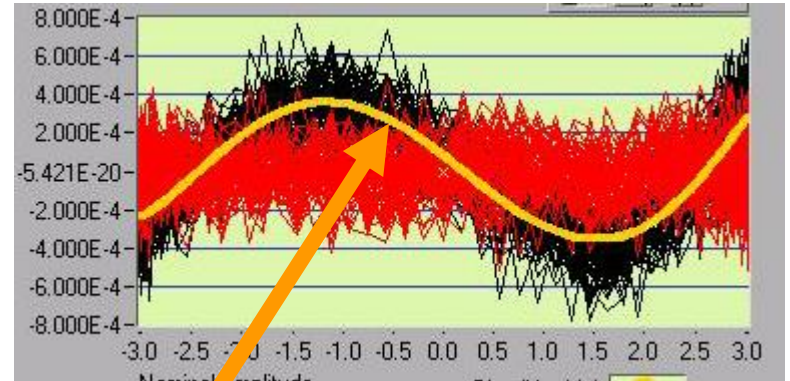
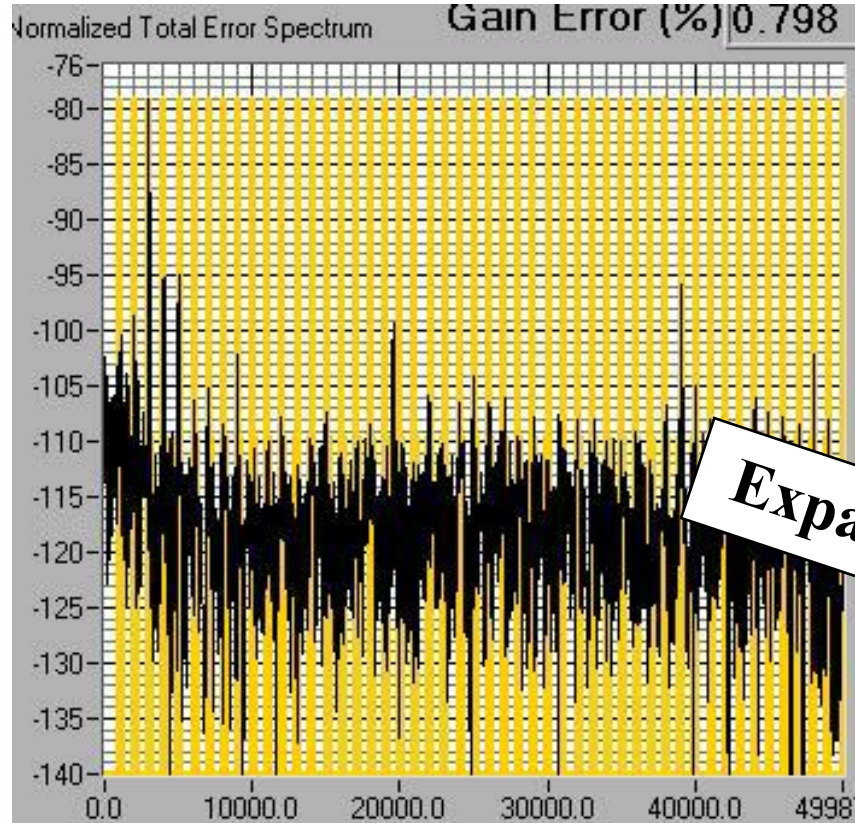
Amplitude

Error Display/Calculation

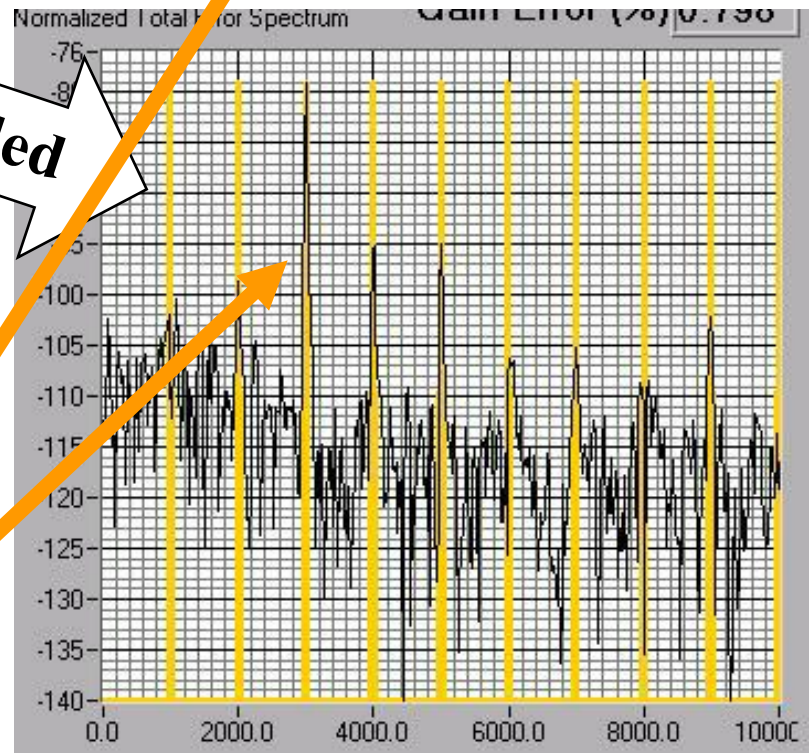


The Spectrum of the Error

Error



Expanded

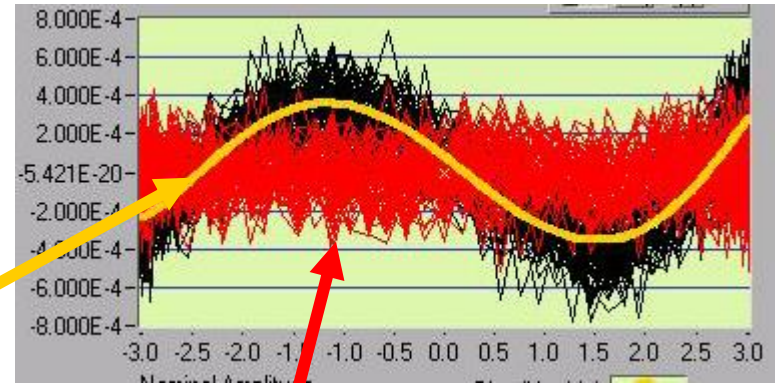


Error Spectrum (Normalized)

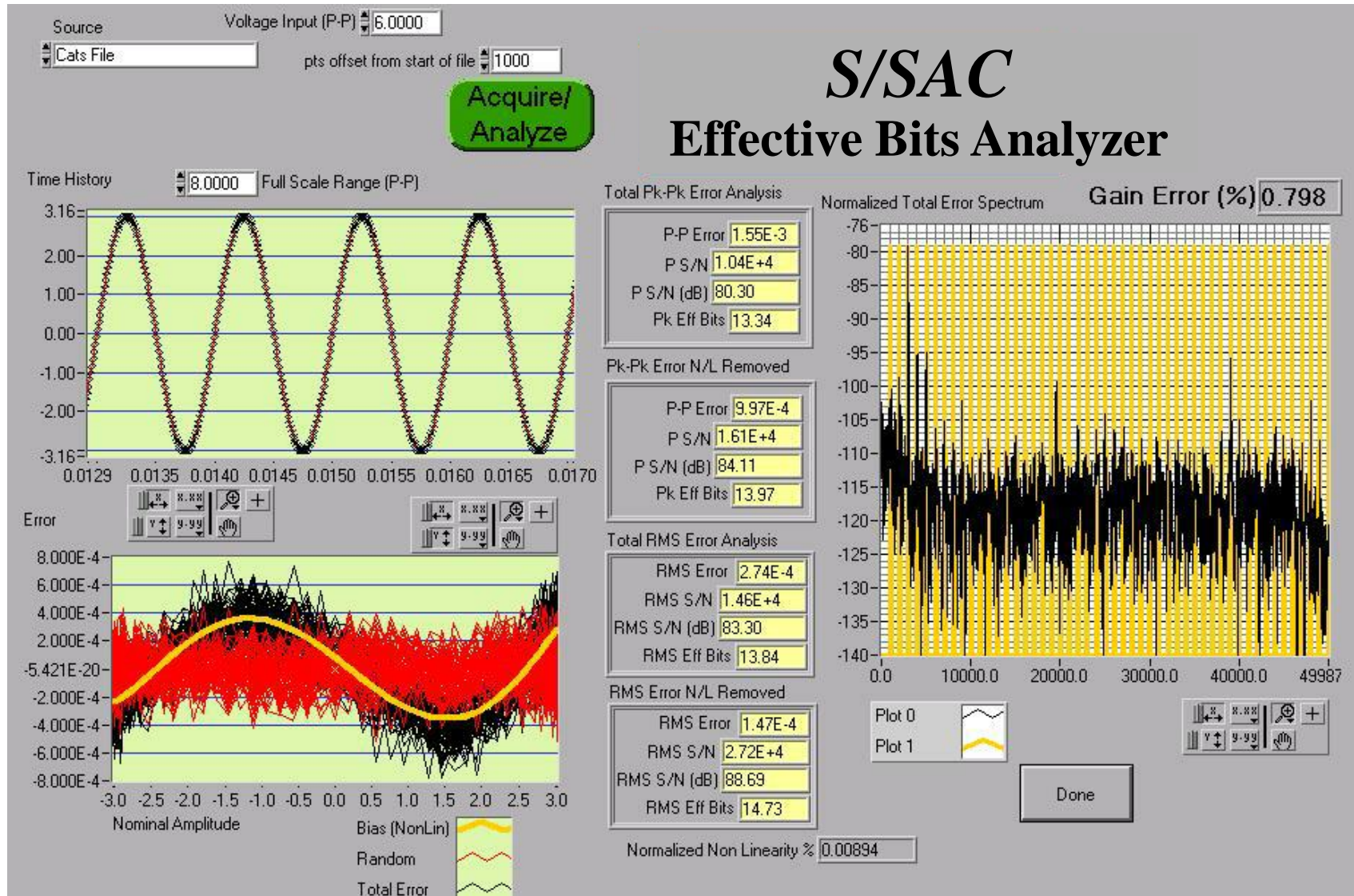
Note:.....
**The Non-Linearity Produces
3rd-Harmonic Distortion**

Calculations

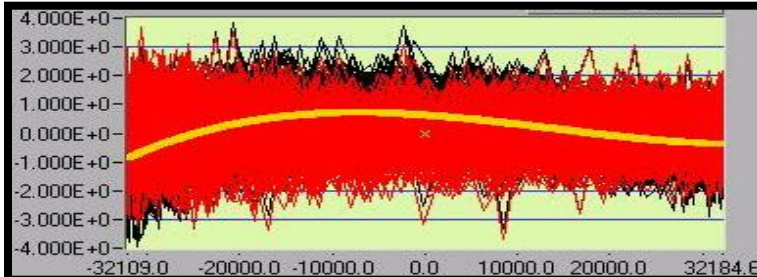
- Do 3rd-Order Least-Square Fit to Error-vs-Amplitude.
 - Characterized Non-Linearity
- Subtract Fit From Error
 - Result is Random Part of the Error
- Find P-P and RMS Values for Total and Random Error.
- Calculate Dynamic Range and Effective Bits
 - Dynamic Range = Full Scale Range/Error
 - Effective Bits = $\log_{10}(\text{Dynamic Range})/\log_{10}(2)$



The Effective Bits Analyzer

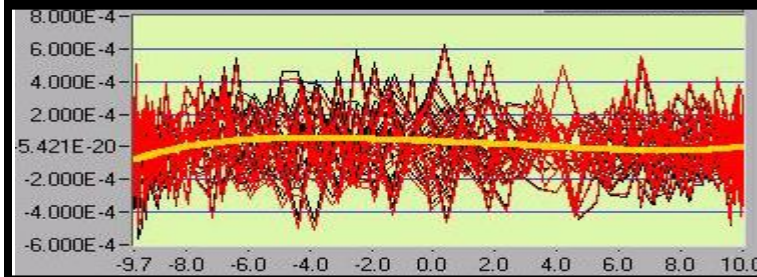


Some Results (16-Bit A/D Converters)



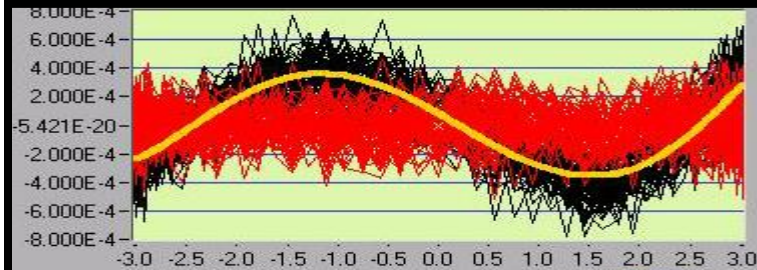
Microstar IDSC (PC) (data in counts)

	Dyn Range(dB)	Eff B
RMS	90.4	15.0
P-P	84.5	14.1
Non Linearity	.0024%	



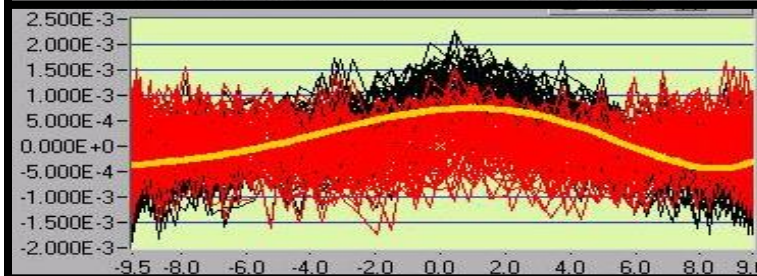
NI 4551 DSA (PC) (with Signal Cond) (data in volts)

	Dyn Range(dB)	Eff B
RMS	88.2	14.7
P-P	84.4	14.0
Non Linearity	.0013%	



Pentek 4275 (VME) (with Signal Cond) (data in volts)

	Dyn Range(dB)	Eff B
RMS	83.3	13.84
P-P	80.3	13.34
Non Lin	.0089%	



VXI A/D (data in volts)

	Dyn Range(dB)	Eff B
RMS	77.9	12.95
P-P	73.6	12.2
Non Lin	.0119%	

Bottom Line(s)

- All Data Acquisition Systems are

Not Created Equal

- *We Have Tested a Few Systems*

... We Want to Do More